

## Photoelectron-spectroscopy study of superconductive $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$

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A photoelectron spectroscopic study was performed to investigate both the fluorine sites in and the electronic structure of superconductive  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  ( $x=0, 0.1, 0.16, 0.2,$  and  $0.3$ ). The x-ray photoelectron spectroscopic (XPS) results for F 1s spectra showed that the doped fluorine ions were located on the oxygen sites in the tetragonal  $\text{Nd}_2\text{CuO}_4$  lattice. Furthermore, comparison between the XPS spectra of  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$ ,  $\text{CuF}_2$ ,  $\text{NdF}_3$ , and  $\text{NdOF}$  suggested that the fluorine ions were not located on the O(2) sites around the  $\text{Nd}^{3+}$  ion but rather on the O(1) sites in the  $\text{CuO}_2$  planes. The XPS result for Cu 2p spectra indicated that the amount of  $\text{Cu}^{1+}$  ions increased as  $x$  increased. In addition, according to the ultraviolet photoelectron spectroscopic measurements, the density of states in the vicinity of the Fermi level seemed to increase as the F content increased.

### I. INTRODUCTION

The superconductivity in  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  (Ref. 1) was discovered just after the appearance of the “ $n$ -type” superconductor  $\text{Nd}_{2-y}\text{Ce}_y\text{CuO}_4$ .<sup>2</sup> It was found that the normal-state properties of  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  were parallel to those of  $\text{Nd}_{2-y}\text{Ce}_y\text{CuO}_4$  from the measurements of transport properties<sup>3-5</sup> and the observation of electronic structure using electron-energy-loss spectroscopy.<sup>6</sup> In contrast to the case of  $\text{Nd}_{2-y}\text{Ce}_y\text{CuO}_4$ , however, there have been only several reports available for  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$ .

In particular, the determination of the sites for doped F ions has been an unresolved problem for  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$ . In the  $\text{Nd}_2\text{CuO}_4$ -type tetragonal lattice,<sup>7</sup> there are two oxygen sites which are called O(1) and O(2) site, respectively: the O(1) site is in the  $\text{CuO}_2$  plane (Cu-O bond) and the O(2) site is between two Nd planes (Nd-O bond). Previously, we suggested<sup>3</sup> that F ions were doped into the O(2) sites based on the lattice parameter measurement results; that is, the  $a$  axis increased in proportion to  $x$  for the samples with  $x < 0.3$ , in spite of the fact that the ionic radius of the  $\text{F}^-$  ion [ $r=0.133$  nm (Ref. 8)] is smaller than that of the  $\text{O}^{2-}$  ion [ $r=0.140$  nm (Ref. 8)]. However, the lattice parameters would be affected by not only the ionic radius but also the charge distribution, when F ions are doped into the sample. Thus, we may not simply conclude that F ions are doped into the O(2) sites.

Unfortunately, it seems impossible to assign sites for doped F ions by neutron diffraction analysis, because the neutron scattering cross section for fluorine is approximately the same as that for oxygen.<sup>9</sup> Furthermore, it was found<sup>4</sup> that the TEM observation gave no significant information on the sites for doped F ions.

On the other hand, photoelectron spectroscopic analysis of core levels can provide the information on the nature of bonding; hence, there is a possibility to identify the position of F ions, if the core-level binding energies in the case of the Cu-F bonding are apparently different

from those of the Nd-F bonding. In addition, a photoelectron-spectroscopic study of the valence band gives the information on the electronic structure; indeed, numerous photoelectron-spectroscopic studies of high- $T_c$  superconductors indicate the existence of an edge structure at the Fermi level.<sup>10</sup> Although some photoelectron-spectroscopic studies<sup>11,12</sup> on  $\text{Nd}_{2-y}\text{Ce}_y\text{CuO}_4$  were already reported, there are, to the authors' knowledge, no reports on the F-doped samples.

In this paper, we report on a photoelectron-spectroscopic study of  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  in order to assign sites for the doped F ions and investigate the change in the electronic structure due to F doping.

### II. EXPERIMENT

The polycrystalline samples of  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  ( $x=0, 0.1, 0.16, 0.2,$  and  $0.3$ ) were synthesized by a solid-state reaction technique using reagent-grade  $\text{Nd}_2\text{O}_3$ ,  $\text{NdF}_3$ , and  $\text{CuO}$  powders. Stoichiometric mixtures of the starting materials were thoroughly mixed by a planetary ball mill using ethanol as solvent. After drying, the mixtures were calcined at  $860^\circ\text{C}$  for 10 h in 20%  $\text{O}_2$ -Ar gas mixture flow. After regrinding, the calcined powder was pressed into rectangular bars and sintered at  $1100^\circ\text{C}$  for 14 h in 1%  $\text{O}_2$ -Ar gas mixture flow. Then, the samples were annealed at  $910^\circ\text{C}$  for 14 h in nitrogen gas flow and furnace cooled to room temperature with a rate of  $\sim 4^\circ\text{C}/\text{min}$ .

Powder x-ray-diffraction studies and electron-probe microanalysis indicated that the samples with  $x \leq 0.2$  were nearly single phase of the  $\text{Nd}_2\text{CuO}_4$ -type tetragonal structure. In contrast, the sample with  $x=0.3$  included small amounts of  $\text{NdOF}$  and  $\text{CuO}$  phases besides the  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  phase. The electrical resistivity and magnetic susceptibility measurements showed that the values of  $T_{c,on}$  were  $\sim 27$  K for the samples with  $x > 0.1$ , though the zero-resistance states were observed only for the samples with  $x=0.2$  and  $0.3$  at 20 and 19 K, respectively. The characterization and physical properties of the sam-

ples are reported in detail elsewhere.<sup>3-5</sup>

The photoelectron-spectroscopic measurements were carried out in an ultrahigh-vacuum system equipped with an Al x-ray source (1486.6 eV) for x-ray photoelectron spectroscopy (XPS) and a noble-gas discharge lamp for ultraviolet photoelectron spectroscopy (UPS). The energy distribution of the photoelectron was determined by an electron-energy analyzer, the resolution of which was set at 0.8 and 0.15 eV for XPS and UPS measurements, respectively. Core-level binding energies were referenced to the adventitious C 1s peak at 285.0 eV. For the UPS measurement, the Fermi energy was determined directly from the zero binding energy of the analyzer, because no charge-up was observed and the accuracy was better than 0.15 eV. The typical pressure during the measurements was  $\sim 2 \times 10^{-10}$  torr. The sample was scraped in vacuum by a diamond file before each measurement. In this study, all of the spectra were taken at room temperature.

### III. RESULTS AND DISCUSSION

#### A. Core-level spectra

The F 1s core-level XPS spectra from  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  ( $x=0, 0.1, 0.16, 0.2,$  and  $0.3$ ) are shown in Fig. 1. The peak observed in the spectrum for each of the F-doped samples indicates that the binding energy of F 1s in  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  is about 684 eV. Since the peak intensity (at  $\sim 684$  eV) increases with  $x$ , the F content in  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  rises with  $x$ , as expected. Furthermore, this increase in the peak intensity at the same binding energy of  $\sim 684$  eV suggests that the F ions are doped into a certain site in the  $\text{Nd}_2\text{CuO}_4$ -type tetragonal unit cell; this is also supported by the fact that the observed binding energy is different from that of F in NdOF, which was the only impurity phase including F ions in the samples, as will be mentioned later.

Figure 2 shows the F 1s XPS spectra from  $\text{Nd}_2\text{CuO}_{3.8}\text{F}_{0.2}$ ,  $\text{CuF}_2$ ,  $\text{NdF}_3$ , and NdOF. There is a marked difference between the top two spectra and the bottom two spectra. The binding energies of F 1s are estimated to be about 683.9, 684.6, and 684.6 eV in  $\text{CuF}_2$ ,

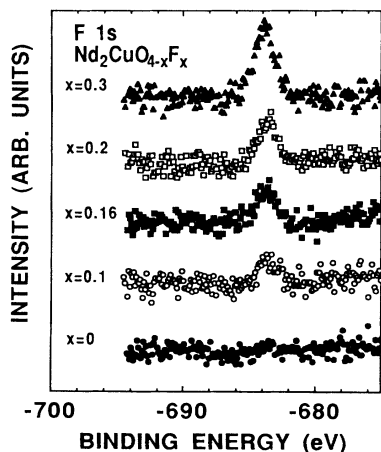


FIG. 1. XPS core spectra of F 1s from  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  with  $x=0, 0.1, 0.16, 0.2,$  and  $0.3$ .

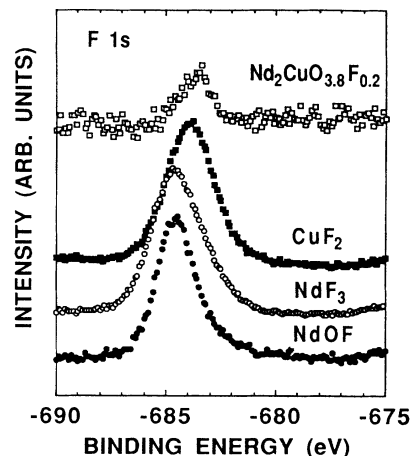


FIG. 2. XPS core spectra of F 1s from  $\text{Nd}_2\text{CuO}_{3.8}\text{F}_{0.2}$ ,  $\text{CuF}_2$ ,  $\text{NdF}_3$ , and NdOF.

$\text{NdF}_3$ , and NdOF, respectively. The binding energy of F in  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  ( $\sim 684$  eV) is close to that in  $\text{CuF}_2$  rather than to those in  $\text{NdF}_3$  and NdOF. This suggests the possibility of the existence of Cu-F bonds in the sample. While it is difficult, based only on the XPS results at this moment, to assign sites for the doped F ions, the similarity of the spectra for F 1s from  $\text{CuF}_2$  and  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  suggests that the F ions are doped into O(1) sites in the  $\text{CuO}_2$  planes. This seems to be against the result of the lattice parameter measurements.<sup>3</sup> However, as described above, it is difficult to assign sites for the doped F ions only from the changes in the lattice parameters.

The XPS spectra for other inner core levels of Nd, Cu, and O are shown in Figs. 3-5. The Nd 3d core-level spectra show no special changes caused by the F doping. Thus, the valence of the Nd ions in  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  is considered to be trivalent. This situation is similar to the case of  $\text{Nd}_{2-y}\text{Ce}_y\text{CuO}_4$ .<sup>10</sup> Additionally, this seems to indicate that the Nd-F bond does not exist in the F-doped samples.

The Cu 2p core-level spectra for  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  are shown in Fig. 4(a). Each spectrum consists of a main

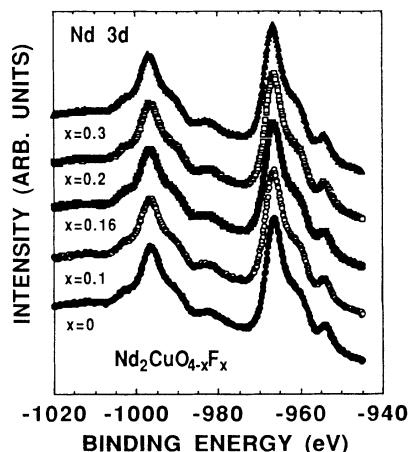


FIG. 3. XPS core spectra of Nd 3d from  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$ .

peak at 932.4 eV and a broad satellite peak at  $\sim 942.5$  eV; usually,<sup>12</sup> the former is assigned to the charge-transfer-screened  $2p3d^{10}L$  final state and the latter is assigned to the unscreened  $2p3d^9$  final state. Since  $F^-$  ion is considered to be a hard base,<sup>13</sup> the substitution of O by F in  $Nd_2CuO_4$  should provide electrons in the  $CuO_2$  planes; as

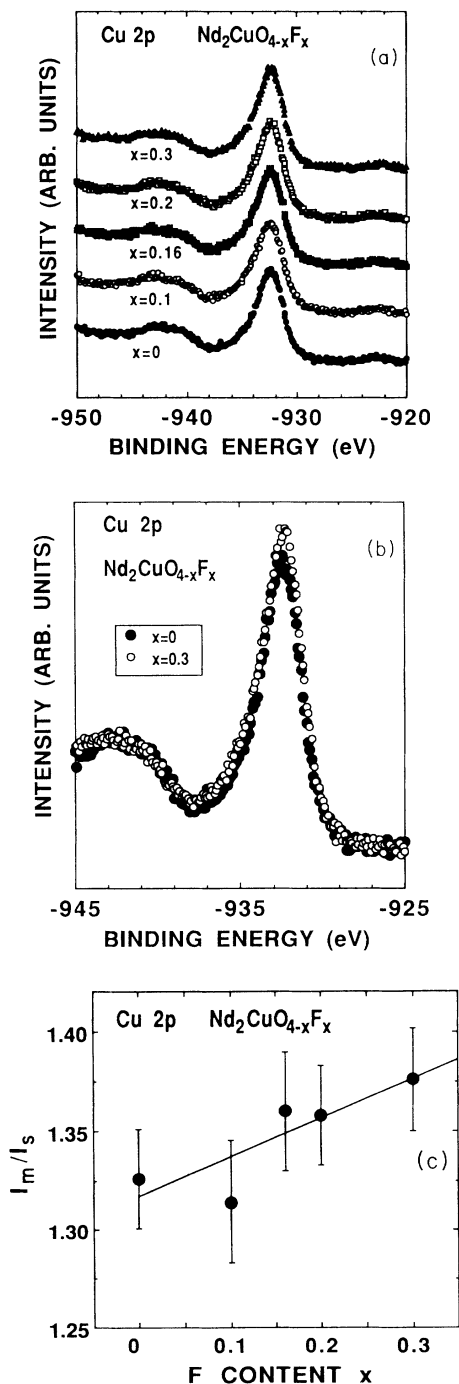


FIG. 4. (a) XPS core spectra of Cu  $2p$  from  $Nd_2CuO_{4-x}F_x$  with  $x=0, 0.1, 0.16, 0.2,$  and  $0.3$ ; (b) the comparison of two XPS spectra of Cu  $2p$  from  $Nd_2CuO_4$  and  $Nd_2CuO_{3.7}F_{0.3}$ ; (c) the relationship between  $I_m/I_s$  and  $x$ , where  $I_m$  and  $I_s$  are the intensity of the main and satellite peak, respectively.

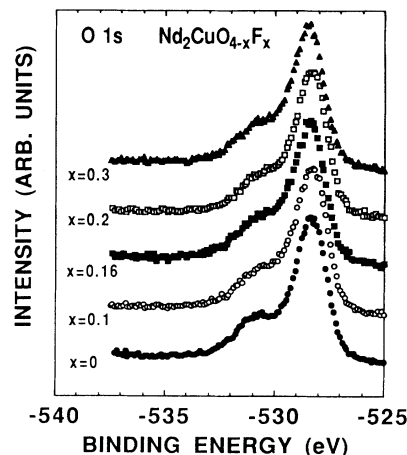


FIG. 5. XPS core spectra of O  $1s$  from  $Nd_2CuO_{4-x}F_x$  with  $x=0, 0.1, 0.16, 0.2,$  and  $0.3$ .

a result, the amount of  $Cu^+$  ions in the sample would increase with  $x$ . Hence, as  $x$  increases, the intensities of the main and satellite peaks are expected to enlarge and reduce, respectively. Indeed, as shown in Fig. 4(b), apparent growth of the main peak is observed, making a comparison between the two spectra for  $Nd_2CuO_4$  and  $Nd_2CuO_{3.7}F_{0.3}$ . To understand the changes in the intensities of the two peaks due to the F doping, Fig. 4(c) shows the main-to-satellite peak intensity ratio  $I_m/I_s$  as a function of  $x$ . It is clearly observed that the magnitude of  $I_m/I_s$  rises in proportion to  $x$ , indicating a linear increase in the amount of  $Cu^+$  ions.

As shown in Fig. 5, the O  $1s$  core-level spectra for  $Nd_2CuO_{4-x}F_x$  consist of the sharp peak at 528.8 eV and the shoulders at  $\sim 531$  eV. It is worth noting that the position of the main peak exhibits no systematic shifts due to F doping. In contrast, for  $Nd_{2-y}Ce_yCuO_4$ , it was observed that the sharp peak at 528.6 eV shifted slightly toward a higher binding energy due to Ce doping.<sup>11</sup> To explain the shift for  $Nd_{2-y}Ce_yCuO_4$ , it was supposed that the oxygen valence increased with  $y$ , such as  $O^{2-} \rightarrow O^{(2-p)-}$ . However, our result implies that the

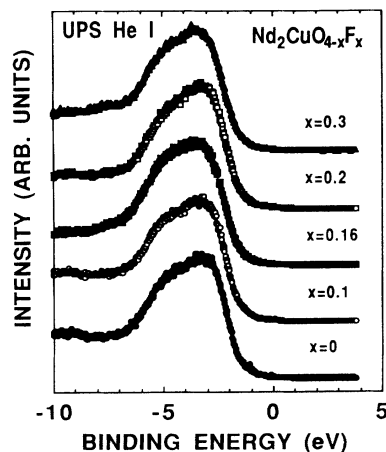


FIG. 6. Valence-band UPS spectra (He I,  $h\nu=21.2$  eV) from  $Nd_2CuO_{4-x}F_x$  with  $x=0, 0.1, 0.16, 0.2,$  and  $0.3$ .

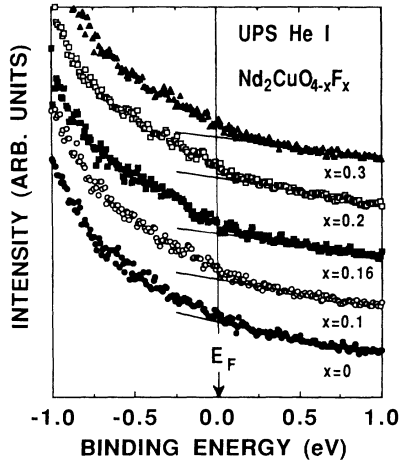


FIG. 7. Enlargement of the UPS spectra of Fig. 6 in the Fermi-level region.

valence of oxygen is not affected by the substitution for O by F. Only the valence of Cu seems to reduce due to F doping. On the other hand, the broad peak at  $\sim 531$  eV is considered to be from the oxide impurities, probably CuO and  $\text{Nd}_2\text{O}_3$ , which are segregated at the voids and/or the grain boundaries. Therefore, although the intensity of the shoulder varies slightly with  $x$ , this change is not an essential feature.

#### B. Valence-band spectra

Figure 6 shows the UPS valence-band spectra for  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$ . The fact that the shapes of the spectra do not change with  $x$  indicates a stable electronic structure to the F doping. In order to understand the detailed electronic structure at the Fermi level ( $E_F$ ), the UPS spectra in the vicinity of  $E_F$  are shown in Fig. 7. For each of the samples with  $x \geq 0.1$ , a finite density of states can be observed at  $E_F$ . Furthermore, as  $x$  increases, the density of states at  $E_F$ ,  $N(E_F)$ , seems to grow. Previously, we reported<sup>3-5</sup> that all of the resistivity, Hall coefficient and thermoelectric-power coefficient reduced in magnitude with  $x$ . This indicated an increase in the charge-carrier density due to F doping. We also pointed out the existence of the insulator-to-metal transition around  $x=0.16$ .<sup>5</sup> The UPS result, which indicates the growth in  $N(E_F)$  with increasing  $x$ , is consistent with the results of the transport properties. However, no drastic differences of the electronic structure between  $x=0$  and 0.2, which might be related to such insulator-to-metal transition, were observed.

Figure 8 shows the UPS results for  $\text{Nd}_2\text{CuO}_4$ ,  $\text{Nd}_2\text{CuO}_{3.8}\text{F}_{0.2}$ , and  $\text{Nd}_{1.85}\text{Ce}_{0.15}\text{CuO}_4$ . Although the difference in shape around 5 eV between  $\text{Nd}_{1.85}\text{Ce}_{0.15}\text{CuO}_4$  and  $\text{Nd}_2\text{CuO}_{3.8}\text{F}_{0.2}$  may suggest the characteristic difference between the Cu  $3d$ -O  $2p$  and

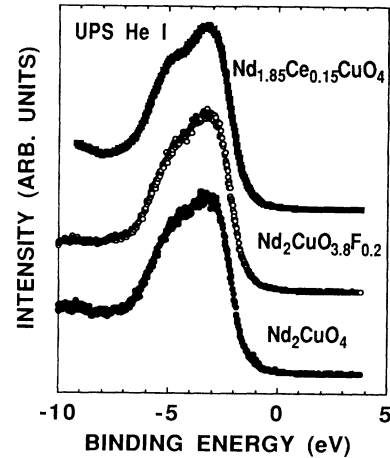


FIG. 8. Valence-band UPS spectra (He I,  $h\nu=21.2$  eV) from  $\text{Nd}_2\text{CuO}_4$ ,  $\text{Nd}_2\text{CuO}_{3.8}\text{F}_{0.2}$  and  $\text{Nd}_{1.85}\text{Ce}_{0.15}\text{CuO}_4$ .

Cu  $3d$ -F  $2p$  hybridization, the overall shapes of the three spectra are quite similar, especially in the vicinity of  $E_F$ . This indicates that the electronic structures of  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  should be approximately the same as those of  $\text{Nd}_{2-y}\text{Ce}_y\text{CuO}_4$ . In fact, the calculated electronic structure using the tight-binding approximation showed<sup>14</sup> that there were no significant differences between  $\text{Nd}_{2-y}\text{Ce}_y\text{CuO}_4$  and  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$ . Furthermore, the calculation indicated that  $E_F$  shifted by 0.34 eV towards the high binding-energy side (comparing with  $\text{Nd}_2\text{CuO}_4$ ) and the value of  $N(E_F)$  was 0.71 states/(eV unit-cell) for  $\text{Nd}_2\text{CuO}_{3.6}\text{F}_{0.4}$ , if the  $\text{F}^-$  ions were doped into only the O(1) sites. Of course, at this moment, it is difficult to estimate the value of  $N(E_F)$  only from the UPS measurements. Nevertheless, the measured photoelectron spectra for  $\text{Nd}_{2-y}\text{Ce}_y\text{CuO}_4$  (Refs. 11 and 12) and  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  seem to be in good agreement with the calculated one.

#### IV. SUMMARY

A photoelectron-spectroscopic study was made in order to investigate both the fluorine sites in and the electronic structure of superconductive  $\text{Nd}_2\text{CuO}_{4-x}\text{F}_x$  ( $x=0, 0.1, 0.16, 0.2$ , and 0.3). The x-ray photoelectron spectroscopic (XPS) results for F  $1s$  spectra showed a possibility that the doped fluorine ions were not located on the O(2) sites around the  $\text{Nd}^{3+}$  ion but rather on the O(1) sites in the  $\text{CuO}_2$  planes. Although the XPS spectra for Nd  $3d$  and O  $1s$  exhibited no significant changes due to F doping, the amount of  $\text{Cu}^+$  ions was found to increase with  $x$  from the XPS spectra for Cu  $2p$ . In the ultraviolet photoelectron-spectroscopic measurements, it was observed that the density of states in the vicinity of the Fermi level also increases with  $x$ , as reported for other high- $T_c$  superconductors.

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